Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/519,944	INOUE ET AL.
Examiner	Art Unit
Yonel Beaulieu	3661

SEARCHED			
Class	Subclass	Date	Examiner
701	36	10/12/2006	ΥВ
	72-74		
	80		
303	147-151		
700	304		
180	168		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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